

**Search Notes**

Application/Control No.

10/775,983

Examiner

Ahshik Kim

Applicant(s)/Patent under  
Reexamination

MEIER ET AL.

Art Unit

2876

**SEARCHED**

| Class | Subclass | Date      | Examiner |
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| 235   | 462.25   | 9/28/2005 | AK       |
| ↓     | 462.26   | ↓         |          |
| ↓     | 462.24   | ↓         |          |
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**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|                                  | DATE       | EXMR |
|----------------------------------|------------|------|
| See attached EAST search history | 9/28/2005  | AK   |
| Updated Search                   | 5/26/2006  | AK   |
| Updated Search                   | 12/10/2006 | AK   |
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